## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10576042	CAVANAGH ET AL.
Examiner	Art Unit
JULIE HA	1654

SEARCHED			
Class	Subclass	Date	Examiner
None			

SEARCH NOTES		
Search Notes	Date	Examiner
EAST and PALM all inventor search	8/11/2008	JH
STIC: can be accessed via eDAN or SCORE	7/1/2008	JH
Interference search: US PG Pub and US Pat Full: (AIKLVQSP).clm.; ((AIKLVQSP) and tinea); ((AIKLVQSP) and fungus and tinea)	8/11/2008	JH
	8/11/2008	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
530	324, 325, 326, 327, 328	8/11/2008	JH
514	2, 12, 13, 14, 15, 16, 17	8/11/2008	JH

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